

Identification and Validation of Analytical Chemistry Methods for Detecting Composite Surface Contamination and Moisture

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FAA Sponsored Project Information





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- Students
 - Rakesh Guduru, Dharam Persaud, Juanjuan Zhou, Yao Ge
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 - David Westlund, Curtis Davies
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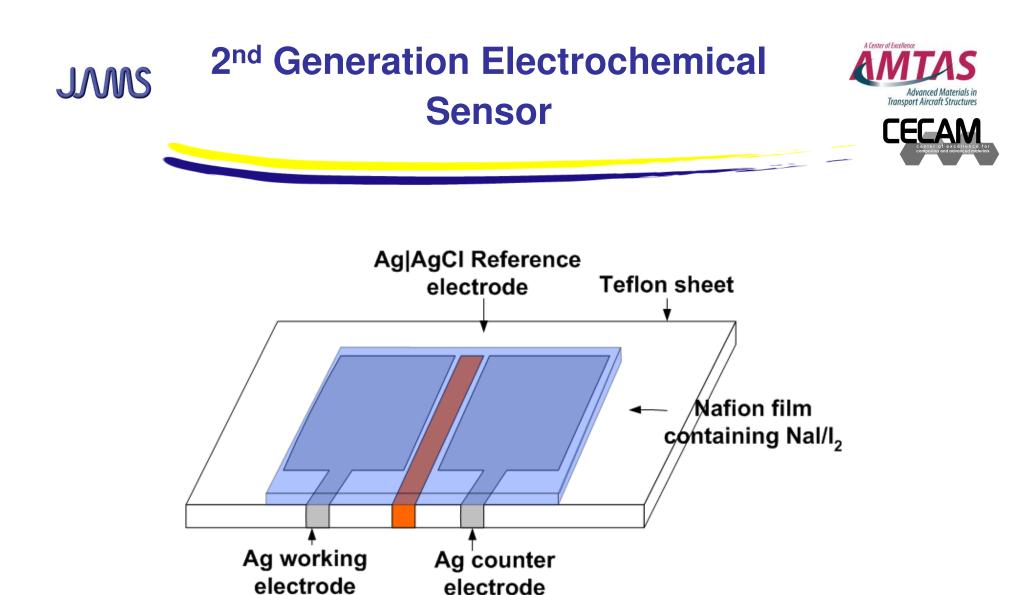


Introduction





- Adhesive bonding is now used in manufacture and repair and is beginning to predominate over mechanical fastening.
- Adherend surface preparation is a critical issue to the structural integrity and durability of bonded structures.
- Objective
 - benchmark knowledge of surface preparation quality assurance methods
 - Identify, evaluate, and validate definitive analytical chemistry methods to provide sufficient in-field quality assurance.
- Approach
 - Literature review and analysis (completed)
 - Surface chemistry analysis
 - Electrochemical sensor evaluation
 - Experimental validation
 - The Joint Advanced Materials and Structures Center of Excellence

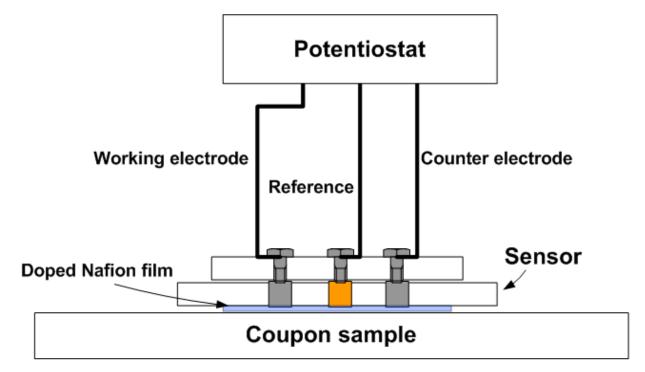




2nd Generation Solid-state Electrochemical Sensor-Experimental Setup

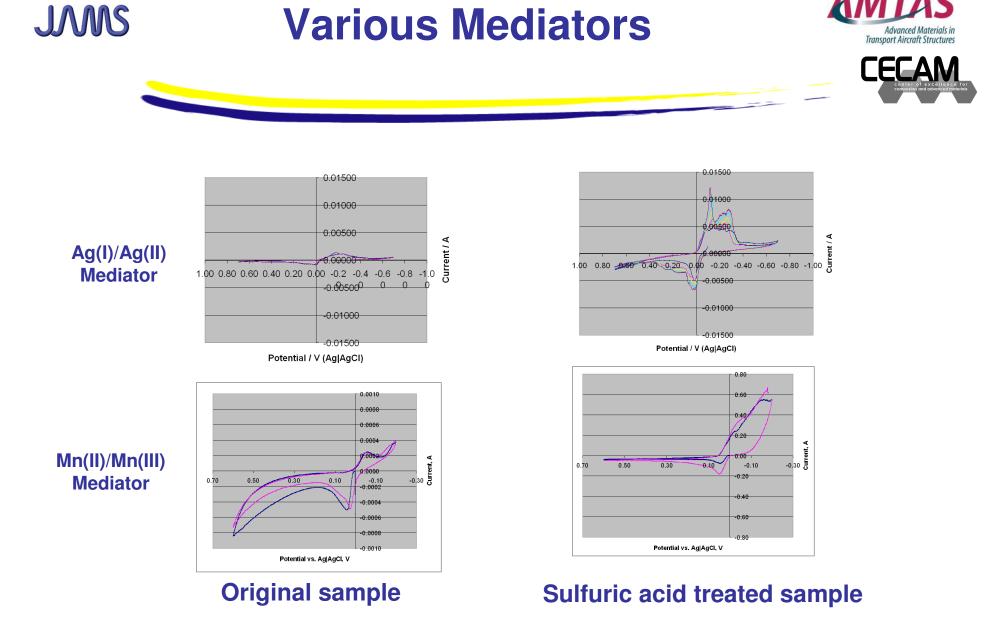








- Original /non-contaminated surface : after removing peel ply
- Polished surface: polished using polishing paper (#600), and wiped with paper.
- Sulfuric acid etched: immersed in 50% sulfuric acid for 1-2 seconds, washed with DI water and dried.

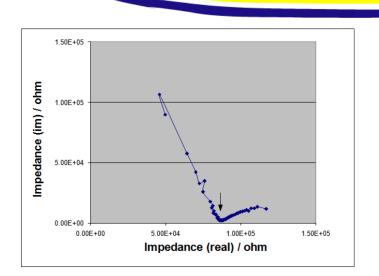


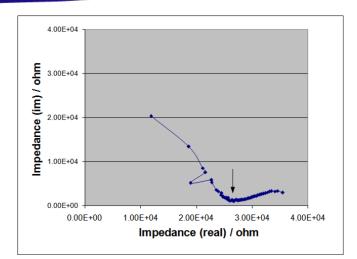
A Center of Excellence

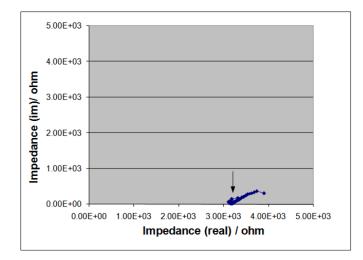
JVVS EIS Results : 2nd Generation Sensor

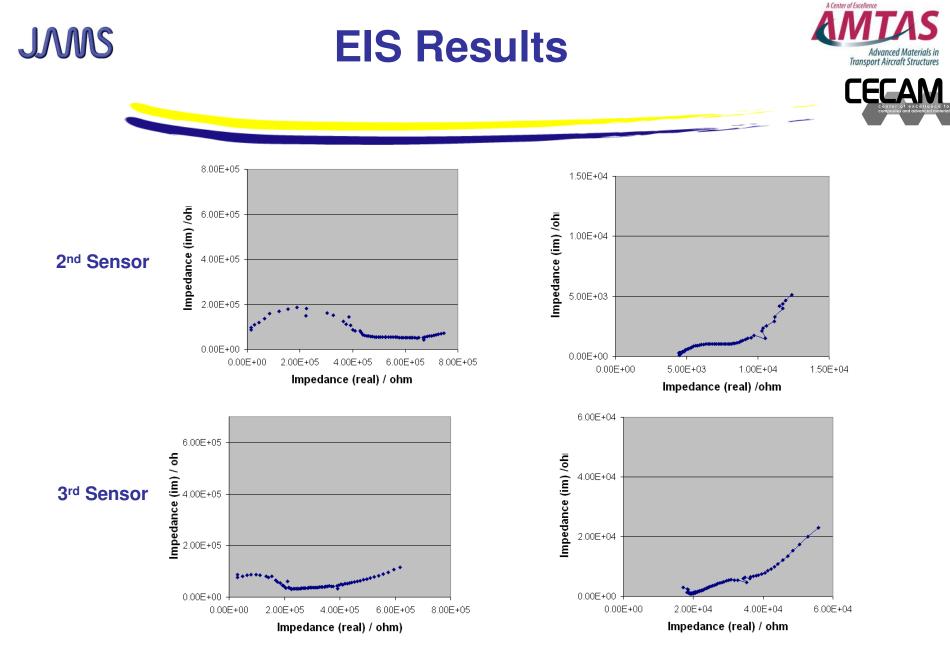








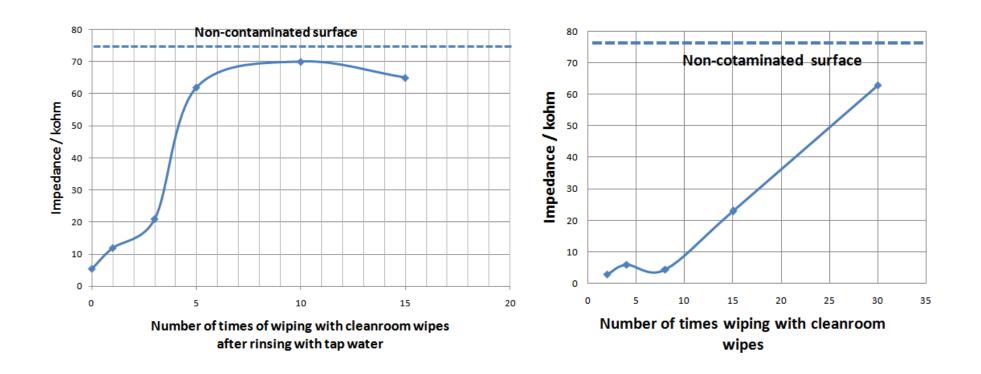




JANS Electrochemical Impedance Spectroscopy



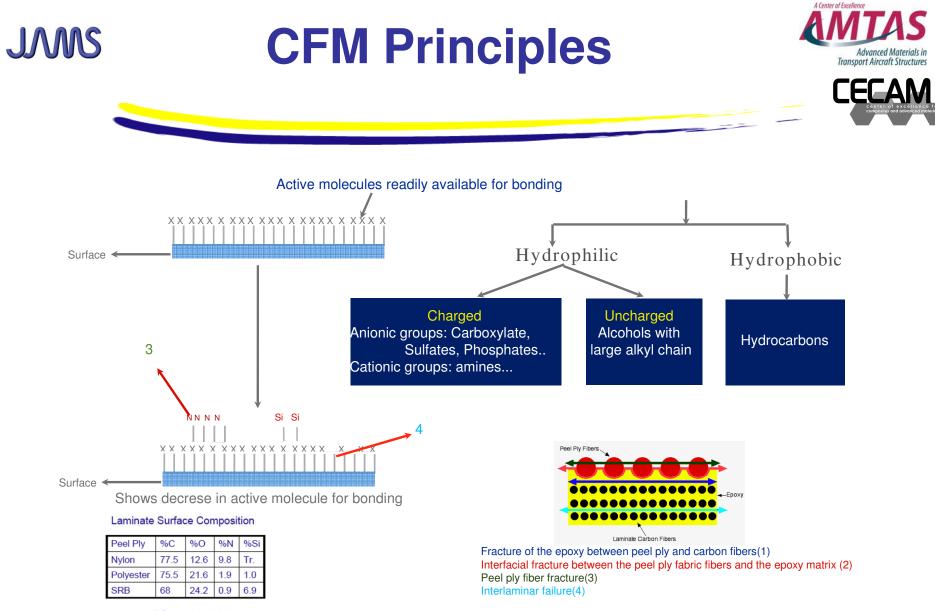






Treatment with sulfuric acid produces

- Hydroxyl, carbonyl, carboxylic acid, phenol, and sulfonated groups, ions, or fragments that may be unstable and can be readily reduced or oxidized at certain potentials.
- The surface chemistry can be analyzed using XPS and FTIR.
- The electrochemical sensor can sense the presence of these groups, ions, or fragments on the surfaces.



XPS results - UW



CHEMICAL FORCE MICROSCOPY 411

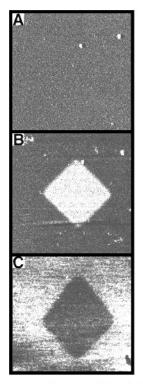


Figure 16 Force microscopy images of a photopatterned SAM sample. The $10 \times 10 \ \mu m$ square region terminates in COM+, and the surrounding region terminates in CH+. The images are of (A) topography. (B) friction force using a tip modified with a COOH-terminated SAM, and (C) friction force using a tip modified with a CH+-terminated SAM. Light regions in (B) and (C) indicate high friction; dark regions indicate low friction (reproduced from Reference 33).

Force microscopy images of a photopatterned SAM sample. The $10 \times 10 \mu m$ square region terminates in COOH, and the surrounding region terminates in CH3.

(A) Topography,

(B) friction force using a tip modified with a COOHterminated SAM,

(C) friction force using a tip modified with a CH3-terminated SAM.

NOTE: Light regions in (B) and (C) indicate high friction; dark regions indicate low friction.

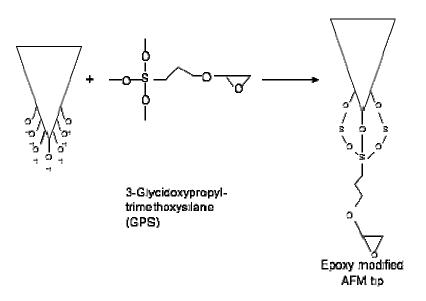


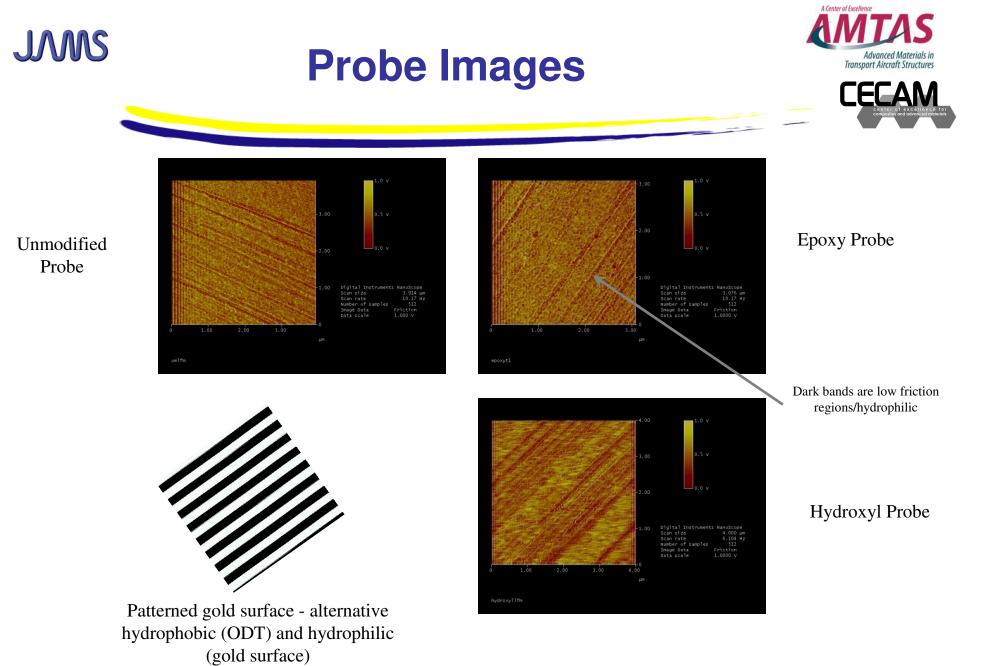


<u>Protocol</u>

- Clean silicon or silicon nitride tips with ethanol for 5 minutes followed by rinsing with milli-Q water for 5 minutes.
- Treat with a freshly prepared acidic mixture (H₂SO₄:H₂O₂) ratio 7:3 v/v for 15 minutes, followed by rinsing with milli-Q water for 5 minutes.
- Dry in vacuum for 10 minutes to remove the water layer on the surface.
- Treat with 2 % 3-
- Glycidoxypropyltrimethoxysilane (GPS) in dry toluene for 2 hrs.
- Rinse with toluene, ethanol and milli-Q water for 3 minutes each.
- Dry in vacuum for 1 hr and store in desiccators until use.









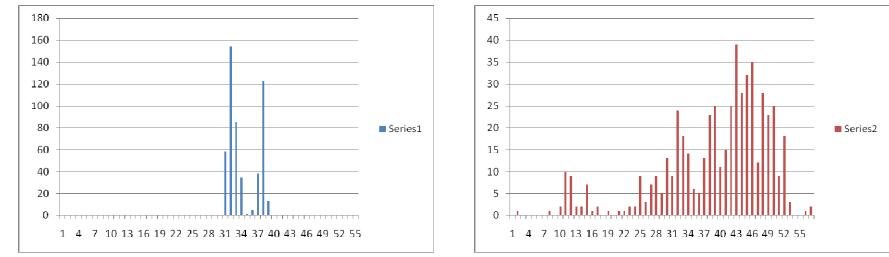
Force Spectroscopy





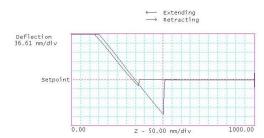
Unmodified Probe

Epoxy Probe









Adhesion Force (nN)

500 force curves at 5 locations on gold coated surface

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- In addition to Nal/I₂, Ag(I)/Ag(II), both Mn(II)/Mn(III) and Cu(I)/Cu(II) are effective mediators for electrochemical sensors.
- In addition to cyclic voltammetry, electrochemical impedance spectroscopy can be a good method for surface inspection.
- The sensitivity and reproducibility are improved with the new design of the sensor.
- A procedure to modify AFM tip probes with the epoxy function group has been achieved and validated with SEM and force spectroscopy.
- Friction force images indicate that contrast between hydrophilic and hydrophobic domains are similar for the epoxy modified tip, hydroxyl modified tip and for the unmodified tip.
- Force spectroscopy results show that the epoxy probe has a higher sensitivity to chemical variations than the unmodified tip probe. The larger adhesion force variation is likely due to the probes ability to detect surface contamination.







- Establish a calibration protocol using a reference laminate surface.
- Integrate the sensor and a micro-potentiostat to make into a handhold measurement device
- Validate the technology with an industrial partner.
- Validate the force spectroscopy data analysis approach with the probe tips on pre-patterned samples.
- Use CFM/force spectroscopy on various peel ply prepared composite surfaces.